

# **Boost LED Driver**

# **2ch Constant Current/Voltage Controller with SPI and I2C Interface for Automotive**

# **BD18354MUF-M**

#### **General Description**

BD18354MUF-M is a 2ch Constant-Current and Voltage Controller. High side current detection amplifier is built in. PWM dimming duty can be freely set with built-in PWM generation circuit. PWM dimming realizes by driving an external P-ch FET. The BD18354MUF-M can support individual 10-bit analog dimming and 10-bit PWM dimming for LED current by programing the 10-bit register via SPI. BD18354MUF-M can be started up by reading data from the EEPROM by setting the MODE pin without SPI communication.

The BD18354MUF-M will support LIMP-HOME mode and STAND-ALONE mode if SPI communication has an error. In the LIMP-HOME mode, it operates by loading the register settings stored in the connected EEPROM. In the STAND-ALONE mode, individual LED current can be set by the external pins and can keep LED current sourcing during applying input power without SPI communication.

#### **Features**

- ◼ AEC-Q100 Qualified *(Note 1)*
- Functional Safety Supportive Automotive Products
- PWM Dimming Signal Generator
- Analog Dimming
- Thermal Shutdown (TSD)
- Thermal Sensor Reading
- Serial Peripheral Interface (SPI)
- Inter-Integrated Circuit (I2C)
- LIMP-HOME Mode
- Outputs Abnormal LED Status (FAULT\_Bx)
- Spread Spectrum Frequency Modulation *(Note 1)* Grade1

# **Typical Application Circuit**

#### **Key Specifications**

- Input Voltage Range: 5.0 V to 70.0 V
- Maximum Output Voltage: 70 V
- 
- LED Average Current Accuracy:  $\begin{array}{r} \text{+3 } \% \\ \text{10-bit Analoa Dimmina Ranae} \qquad \qquad 5 \% \text{ to 100 } \% \end{array}$ ■ 10-bit Analog Dimming Range
- Programmable Switching Frequency Range:
- 100 kHz to 2.5 MHz
- ◼ Junction Temperature Range: -40 °C to +150 °C

#### **Applications**

**Automotive Exterior Lamps** Rear, Turn, DRL/Position, Fog, High/Low Beam etc.

**Package W (Typ) x D (Typ) x H (Max)**

VQFN40FV6060 6.0 mm x 6.0 mm x 1.0 mm





〇Product structure : Silicon integrated circuit 〇This product has no designed protection against radioactive rays.

# **Pin Configuration**





# **Block Diagram**



# **Absolute Maximum Ratings (Ta = 25 °C)**



 $(x = 1, 2)$ 

Caution 1: Operating the IC over the absolute maximum ratings may damage the IC. The damage can either be a short circuit between pins or an open circuit *between pins and the internal circuitry. Therefore, it is important to consider circuit protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.*

*Caution 2: Should by any chance the maximum junction temperature rating be exceeded the rise in temperature of the chip may result in deterioration of the properties of the chip. In case of exceeding this absolute maximum rating, design a PCB with thermal resistance taken into consideration by increasing board size and copper area so as not to exceed the maximum junction temperature rating.*

# **Thermal Resistance***(Note 1)*



*(Note 5)* This thermal via connect with the copper pattern of layers 1,2, and 4. The placement and dimensions obey a land pattern.

# **Recommended Operating Conditions**



 $(x = 1, 2)$ 

*(Note 1)* ASO should not be exceeded.

# **Recommended Setting Parts Range**



 $(x = 1, 2)$ 

*(Note 2)* Set the capacitor in consideration of temperature characteristics and DC bias characteristics.

(Unless otherwise specified  $V_{\text{IN}}$  = 13 V,  $V_{\text{EN}}$  = 5 V, Tj = -40 °C to +150 °C)



# **Electrical Characteristics - continued**

(Unless otherwise specified  $V_{\text{IN}}$  = 13 V,  $V_{\text{EN}}$  = 5 V, Tj = -40 °C to +150 °C)



 $(x = 1, 2)$ 

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# **Electrical Characteristics - continued**

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# **Electrical Characteristics - continued**

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 $(x = 1, 2)$ 

(Unless otherwise specified  $V_{IN}$  = 13 V, V<sub>EN</sub> = 5 V, Tj = -40 °C to +150 °C)



 $(x = 1, 2)$ 

# **Description of Blocks**

From this page onward, 'x' used in the symbol means  $x = 1$ , 2.

#### **1 Power Supply for N-ch MOSFET Gate Driver and Internal Circuit (VDRV7)**

The VDRV7 pin voltage 7.5 V (Typ) is generated from the VIN pin voltage. This voltage is used as the power supply for driving the DC/DC N-ch MOSFET. The total current supplied to the DC/DC N-ch MOSFET and the resistor must be IDRV7LM (VDRV7 output current limit) or less.

The current supplied to the DC/DC N-ch MOSFET (IMOSFET) can be calculated by the following formula.

$$
I_{MOSFET} = Q_G \times f_{SW}
$$

Where:

 $Q_G$  is the gate charge of the MOSFET.

 $f_{SW}$  is the switching frequency.

Connect C<sub>VDRV7</sub> = 4.7 µF as feedback compensation capacitor to the VDRV7 pin. Place ceramic capacitor close to the IC to minimize trace length to the VDRV7 pin and also to the IC ground.

Do not use the VDRV7 pin as a power supply other than this IC.

#### **2 Internal Reference Voltage (VREG5)**

The VREG5 pin voltage 5.0 V (Typ) is generated from the VIN pin voltage. This voltage is used as the internal power supply of the IC. The total current drawn from the VREG5 pin must be IREG5LM (VREG5 Output Current Limit) or less. Connect  $C_{VREG5} = 4.7$  uF as feedback compensation capacitor to the VREG5 pin. Place ceramic capacitor close to the IC to minimize trace length to the VREG5 pin and also to the IC ground. Do not use the VREG5 pin as a power supply other than this IC.

#### **3 LED Current Setting (CURRENT SENSE)**

LED current (I<sub>LED</sub>) can be set by resistor R<sub>SNSx</sub> connected between the SNSPx pin and the SNSNx pin and can be programmed by SPI register ISETx[9:0]. The internal Rail-to-Rail current sense amplifier monitors the LED current with the differential voltage (V<sub>SNSx</sub>) divided by R<sub>SNSx</sub> between the SNSPx pin and SNSNx pin and generates a scaled output voltage  $V_{\text{ISETx}}$  given as  $V_{\text{SNSx}}$  x12 plus 0.2 V offset. The internally scaled output voltage  $V_{\text{ISETx}}$  will be compared to the reference voltage V<sub>DCDIMx</sub> by the GM error amplifier to generate an error signal. This output error signal will be integrated by the compensation capacitor C<sub>COMPx</sub> connected to the COMPx pin. The Internal reference voltage V<sub>DCDIMx</sub> is the output of the 10bit DAC converter and the DAC full scale range is 2.5 V ( $V_{FSRADC}$ ), same with the internal 10 bit ADC. Programmable LED average current can be calculated by the following formula.

$$
I_{LEDxAVE} = \frac{V_{SNSxAVE}}{R_{SNSx}} = \frac{V_{DCDIMx} - 0.2 V}{12 \times R_{SNSx}} = \left(\frac{ISETx[9:0]}{1024} \times V_{FSRADC} - 0.2 V\right) \times \frac{1}{12 \times R_{SNSx}}
$$
 [A]

#### Where:

 $V_{SNSXAVE}$  is the average current sense regulation voltage set by ISETx[9:0].  $V_{DCDIMx}$  is the internal reference voltage of the GM amplifier to define the V<sub>SNSx</sub>.

 $V_{FSRADC}$  is the reference voltage of the 10bit DAC that outputs the V<sub>DCDIMx</sub>.



Figure 1. LED Current Setting

# **3 LED Current Setting (CURRENT SENSE) - continued**



Figure 2. Current Sense Regulation Voltage Setting



#### **4 Slow Startup**

BD18354MUF-M can select slow startup function by setting the SPI register EOVPx/SSUx = 1 and the SSUx pin H/L. When the SSUx pin = H,  $ISETx[9:0]$  is incremented from  $ISETx[0]$  to  $ISETx[9:0]$  for each tssux at startup. tssux can be calculated by the following formula.

$$
t_{SSUx} = \frac{1}{f_{PWM} \times SSU_{DIVx}} \times ISETx[9:0] \text{ [s]}
$$

Where:

 $f_{PWM}$  is the PWM dimming frequency.

 $SSU_{DIVx}$  is the is a division factor provided in slow startup register.

 $ISET_x[9:0]$  is the SPI register to set LED current.





### **5 Voltage Regulation**

The BD18354MUF-M supports "voltage regulation mode" when the VMODEx bit is set in the DCDCSET2 register. In the voltage regulation mode, the BD18354MUF-M regulates the SNSNx pin voltage (VSNSNx) by control inductor peak current in average voltage sensing feedback loop. The Internal reference voltage V<sub>DCDIMx</sub> is the output of the 10bit DAC converter and this DAC full scale range is 2.5 V (VFSRADC) same with the internal 10bit ADC.

Programmable VOUTx average  $(\dot{V}_{\text{OUTXAVE}})$  voltage can be calculated by the following formula.

When VMODEx = 1, it is automatically set to V<sub>SNSxSCP</sub> = 163.4 mV (V<sub>SNSxAVE</sub> = 0 V).

Short the SNSPx and SNSNx pins or mask the SCP function with the register setting SCPxMASK = 1.

$$
V_{OUTX\_AVE} = \frac{V_{DCDIMx} \times 75}{2.5} = \frac{ISETx[9:0]}{1024} \times \frac{V_{FSRADC} \times 75}{2.5}
$$
 [V]

Where:

 $V_{DCDIMx}$  is the internal reference voltage of the GM amplifier to define the VsNsx.

 $V_{FSRADC}$  is the reference voltage of the 10bit DAC that outputs VDCDIMx.





#### **6 PWM Dimming (PWMDIM)**

6.1 External P-ch MOSFET Drive

The PDRVx pin drives an external P-ch MOSFET to achieve PWM dimming. Connect the gate of the P-ch MOSFET to the PDRVx pin. The PDRVx pin outputs SNSPx and SNSPx - 8 V (Typ).

At start up and restart (After UVLO, TSD, SCP, OVP is released or start up.), after DC/DC starts switching, the PDRVx pin can output SNSPx - 8 V (Typ).

The PDRVx output voltage and the DC/DC output voltage (SNSPx pin voltage) have the characteristics shown below figure. When the number of LED lights is small, design and evaluate in consideration of the characteristics shown below figure. There is a possibility that the external P-ch MOSFET cannot be driven.



Figure 3. PDRVx Output Low Voltage vs SNSPx Pin Voltage

#### 6.2 Rush Current Limit Drive Circuit

Rush current limit (CLIM) function is enabled when register CURLIMENx = 1. This is a function that suppresses inrush current flowing into the LED due to the discharge current that occurs when the number of LED lights changes. The limited current value when the CLIM function is activated is  $V_{\text{SNSxCLIM}} = V_{\text{SNSx}} + 50 \text{ mV(Typ)}$ . When ISETx[9:0] = 1023, VSNSxCLIM = 241.5 mV.

When an overcurrent occurs to the LED and the voltage between the SNSPx pin and SNSNx pin exceeds VSNSXCLIM, the external PMOS turns OFF. 10 µs after PMOS = OFF, the LED will restart lighting with the current suppressed by the V<sub>SNSxCLIM</sub> voltage. At this time, the output current is linearly controlled by an external PMOS. When the discharge current disappears, the external PMOS returns to the ON state. This function is effective when PWM dimming is not used and the SNSNx pin voltage > 7.4 V or more. The function is automatically turned off when SNSNx pin voltage = 7.1 V or less. In addition, the current limit drive function is masked when the SNSNx pin voltage drops below VIN pin voltage + 2.2 V.

$$
I_{LED\_LIM} = \frac{V_{SNSxCLIM}}{R_{SNSx}} = \frac{V_{SNSx} + 50 \, \text{mV}}{R_{SNSx}} \, \text{[A]}
$$



Figure 4. Current Limit Drive Circuit and Waveforms

#### **6 PWM Dimming (PWMDIM) - continued**

6.3 Internal PWM Dimming Setting

The BD18354MUF-M has an internal 10-bit PWM dimming generator to make timing for individual Boost converter switching ON/OFF. The internal PWM dimming ON duty cycle (DPWMONx) is set by the SPI register the DPWMx[9:0]. PWM dimming frequency fewm can be set by the SPI register the PWMDIV[2:0] and this PWM dimming frequency setting is common to all boost channels for synchronous PMW dimming within the device itself. Except for DPWMx[9:0] = 0 setting.

$$
D_{PWMONx} = \frac{DPWMx[9:0] + 1}{1024}, \qquad t_{PWMONx} = \frac{D_{PWMONx}}{f_{PWM}}
$$

Regardless of the above formula, the internal PWM dimming ON duty cycle (DPWMONX) is set to 0 % when DPWMx [9:0]  $= 0$  is set.



6.4 External PWM Dimming Setting

PWM dimming ON time t<sub>PWMONx</sub> is controlled by the internal PWM dimming generator or an external PWM dimming control thru the PWMDx pin. If the PWMDx pin is set to high level,  $t_{\text{PWMONx}}$  is 100 % ON duty. If the PWMDx pin is set to low level, t<sub>PWMONx</sub> is equal to the internal PWM ON cycle (D<sub>PWMONx</sub>).

In case of PWM dimming setting D<sub>PWMONx0%</sub> (initial), the PWMDx pin can be used for external PWM dimming control for LED current ON/OFF.

6.5 Hybrid External Analog and PWM Dimming Setting

The BD18354MUF-M supports "external analog dimming mode" when the STAND-ALONE state. In the external analog dimming mode, internal reference voltage for current regulation can be defined by the PWMDx pin voltage (V<sub>PWMDx</sub>). When the external reference voltage V<sub>PWMDx</sub> is lower than internal reference voltage V<sub>DCDIMx</sub>, feed-back voltage V<sub>ISNSx</sub> will be regulated by the external one. In case of using analog dimming and PWM dimming by the PWMDx pin, applying PWM peak voltage defines analog dimming level ILEDxAVE and PWM duty (D<sub>PWMON</sub>) defines PWM dimming ON time tewmon. The analog dimming reference peak voltage V<sub>PDxPK</sub> can be set by the voltage divider  $(R_{PDX1}$  and  $R_{PDX2}$ ) and PWM duty (D<sub>PWMON</sub>) control by external NPN transistor by applying invert PWM signals (PWMx\_B).



6.5 Hybrid External Analog and PWM Dimming Setting – continued



Figure 5. Hybrid External Analog and PWM Dimming



Figure 6. Hybrid External Analog and PWM Dimming Waveforms

#### **7 Analog Dimming**

BD18354MUF-M has two systems of analog dimming function in addition to the analog dimming by the PWMDx pins.

7.1 PWMDx Pin Analog Dimming Setting When the STAND-ALONE state, Internal reference voltage for current regulation can be defined by the PWMDx pin voltage (VPWMDx). When the external reference voltage VPWMDx is lower than the internal reference voltage VDCDIMx, feed-back voltage V<sub>ISNSx</sub> will be regulated by the external one. When the PWMDx pin (The lower voltage takes precedence) becomes V<sub>DCDIMx</sub> or less, the LED current decreases. When not using the analog dimming function, set it to 3 V or more.

When the analog dimming rate is low, DC/DC control may become unstable and the LED may flicker. Confirm enough in the evaluation.



Figure 7. VSNSXAVE VS VPWMDx (PWMDx Pin Analog Dimming)

#### **7 Analog Dimming - continued**

7.2 VIN Pin, NTCx Pin and BINx Pin Dimming Setting

Setting the SPI register ADMODE = 1 enables input voltage dimming using the VIN pin, temperature dimming using the NTCx pin, and BIN dimming using the BINx pin.

In input voltage dimming, when the input voltage  $(V_{\text{IN}})$  drops, the output current is reduced to prevent the input current from increasing. The derating start voltage V<sub>INDIM</sub> can be set by the SPI register the VINDSETx[1:0]. The derating gain (VINDGAIN) is set by the SPI register the VINDGAINx[1:0].

The thermal derating performs dimming control according to temperature changes by connecting an NTC element. The derating start voltage  $V_{NTCx}$  can be set by the SPI register the NTCSETx[7:0]. The derating gain ( $V_{NTCx}$  GAIN) is set by the SPI register the NTCGAINx[1:0].

Voltage sampling of VIN pin and NTCx pin is performed every 128 µs, and the value of ISETDx[9:0] is updated. In the BIN dimming, the LED current can be adjusted by selecting the BINx pin voltage (V<sub>BINx</sub>) and the BIN table set by the BINSELx[1:0] register. BIN dimming is reflected when starting with CHONx = 1.

The LED average current during derating can be calculated by the following formula.

 $I_{LEDxAVE} = \frac{V_{SNSxAVE}}{P_{SING}}$  $\frac{SNSxAVE}{R_{SNSx}} = \left(\frac{ISETDx[9:0]}{1024}\right)$  $\frac{TDX[9:0]}{1024} \times V_{FSRADC} - 0.2 V \times \frac{1}{12 \times R}$  $\frac{1}{12 \times R_{SNSX}}$  [A]

 $ISETDx[9:0] = ISETNTCx[9:0] + (VIND[9:0] - VINDSETx[1:0]) \times VINDGAINx[1:0]$ 

 $ISETNTCx[9:0]$ 

 $=$   $ISETx[9: 0] + BINVALx$  $+$  ( $VNTCx[9: 0] - NTCSETx[7: 0]) \times NTCGAINx[1: 0]$ 

Where:

 $V_{SNSxAVE}$  is the average current sense regulation voltage.  $R_{SNSX}$  is the resistor of the LED current setting.  $ISTDx[9:0]$  is the SPI register for setting LED average current during all derating operation.  $V_{FSRADC}$  is the reference voltage of the 10bit A/D.

 $ISTNTCx[9:0]$  is the SPI register for setting LED average current during NTC derating operation.  $VIND[9:0]$  is the voltage of the AD conversion of the VIN pin voltage.  $VINDSETx[1:0]$  is the SPI register that sets the input voltage derating start voltage.  $VINDGAINx[1:0]$  is the SPI register that sets the input voltage derating gain.

 $ISETx[9: 0]$  is the SPI register to set LED average current.  $BINVALx$  is the value from the BIN table set by the SPI register BINSELx[1:0].  $VNTCx[9:0]$  is the voltage of the AD conversion of the NTCx pin voltage.  $NTCSETx[7: 0]$  is the SPI register that sets the NTC start voltage.  $NTCGAINX[1: 0]$  is the SPI register that sets the derating gain.



Figure 8. LED Current During Derating

7.2 VIN Pin, NTCx Pin and BINx Pin Dimming Setting - continued The Functions enabled by ADMODE setting.



The input voltage derating start voltage VINDSET set by the SPI register VINDSETx[1:0].



The input voltage derating GAIN VINDGAIN set by the SPI register VINDGAINx[1:0].



Dimming example of the VIN pin:

Condition: VINDSETx[1:0] = 1 (initial), VINDGAINx[1:0] = 2 (initial),

BINSELx[1:0] = 0, NTCSETx[7:0] = 127 (initial), NTCGAINx[1:0] = 2 (initial)







# 7.2 VIN Pin, NTCx Pin and BINx Pin Dimming Setting - continued

The BINVALx set by the SPI register BINSELx[1:0] (See BIN table below).



Dimming example of the BINx pin: Condition: ISETx[9:0] = 901 (initial), BINSELx[1:0] = 2



7.2 VIN Pin, NTCx Pin and BINx Pin Dimming Setting - continued

The thermal derating start voltage  $V_{NTCSETX}$  set by the SPI register NTCSETx[7:0].





The thermal derating GAIN NTCGAINx set by the SPI register NTCGAINx[1:0].



Dimming example of NTCx pin: Condition: BINSELx[1:0] = 0, NTCSETx[7:0] = 127 (initial), NTCGAINx[1:0] = 2 (initial)





Figure 10. VSNSXAVE VS VNTCx (Thermal Derating)  $(NTCSETx[7:0] = 127, NTCGAINx[1:0] = 2)$ 

#### **8 Enable Setting (the EN Pin, the MODE Pin)**

8.1 Device Enable (the EN Pin)

The BD18354MUF-M can be enabled or disabled via the EN pin. When the EN pin is pulled low, the device is shutdown and the device's quiescent current is reduced to I<sub>INSTB</sub>. In the shutdown state, the internal regulator is turned off and the registers are reset. When the voltage is ON and the EN pin increases beyond the voltage threshold of  $V_{EN}$ , two channels can be enabled. (Refer to ["Start-up & Turn-off Sequence"](#page-66-0).)

When pulling up the EN pin to the power supply, be sure to connect it with a resistor of 10 kΩ or more. (If the adjacent pin is short-circuited, the power supply - GND will be short-circuited.)

8.2 Startup Mode Select (the MODE Pin)

The BD18354MUF-M can select startup sequence by the MODE pin H/L. When the MODE pin = L, CHx can be turned ON/OFF individually by the SPI signal. When the MODE pin = H, it starts up in EEPROM read operation. (Refer to ["Start-up & Turn-off Sequence"](#page-66-0).)

#### 8.3 Startup Model Select (the MSEL Pin)

When booting with EEPROM read operation, the data set to be read from the EEPROM can be specified by setting the MSEL pin voltage.

The table below shows the relationship between the MSEL pin voltage and the data set to be read. It also shows an example of the resistance value connected to the VREG5 pin voltage.



#### **9 Soft Start (SSDAC)**

For soft-start to reduce rush charge output current, a programmed soft-ramp-up reference voltage (VDCDIMx) or a soft-rampup the COMPx pin voltage by more compensation capacitor (C<sub>COMPx</sub>) can be used. The COMPx pin voltage clamped by SSDAC output until the LED current or the output voltage approaches the regulation threshold. The soft-start is controlled with a 10bit DAC which ramps from 0 V to 2.5 V during startup of an associated channel. The rate of the soft-start ramp (or the ramp time) can be controlled by programming the clock of the internal digital ramp counter. When the soft-start is completed, the internal SSENDx signal becomes H. Set  $SSETx[2:0]$  when  $CHONx = 0$ .

Programmable soft-output-start can be calculated by the following formula.

$$
t_{SSx} = \frac{ISETx[9:0] \times SS_{DIVx}}{f_{SWx}}
$$
 [s]

Where:

 $f_{SWx}$  is the switching frequency set by the SPI register FRT[3:0] and the external resistor (RRT).  $SS_{DIVx}$  is the is a division factor provided in soft-start register.





Set the soft-start time longer than the time required to charge the output capacitor. The soft-start time is counted up only the PWM dimming signal = H section. The count value is retained in the PWM dimming signal = L section.

#### **10 Switching Frequency Setting (OSC)**

The BD18354MUF-M has the OSC circuit generating an adjustable frequency fsw set by the SPI. The switching frequency is set by the SPI register FRT[3:0] and an external resistor  $(R_{RT})$ .

With a clock signal input to the SYNC pin, the internal oscillation frequency can be synchronized externally. Input a 50 % duty external input frequency with less than ±20 % of internal oscillating frequency set by the RT pin resistance. When PHSHFT = 0 is set, the falling edge of the clock input to the SYNC pin is synchronized with the oscillation frequency. When PHSHFT = 1 is set, the falling edge of the clock input to the SYNC pin is synchronized with the oscillation frequency of CH1, and the rising edge is synchronized with the oscillation frequency of CH2.

Since OSC signal dropout occurs when switching operations, it is recommended that switching between internal OSC and SYNC operations be performed with CHONx = 0.

For SYNC operation, set SSFM[2:0] = 0.

$$
f_{SW} \approx \frac{(FRT[3:0] + 1) \times k}{R_{RT}}
$$
,  $(k = 3125 \times 10^6)$ 

\*Only the range from 100 kHz to 2.25 MHz can be set.



Figure 11. DC/DC OSC Setting by the SYNC and RT Pins



Figure 12. DC/DC Switching Frequency: fsw vs FRT[3:0] (RRT = 47 k $\Omega$ )

# **10 Switching Frequency Setting (OSC) – continued**





FRT (Dec)	DC/DC Frequency [kHz]
	68
1	133
2	200
3	261
4	336
5 (initial)	399
6	460
7	522
8	588
9	648
10	710
11	768
12	840
13	899
14	956
15	1014

Table 1. DC/DC Frequency Setting ( $R_{RT}$  = 47 k $\Omega$ )

# **10 Switching Frequency Setting (OSC) – continued**



#### **11 Spread Spectrum Frequency Modulation (SSFM)**

The BD18354MUF-M has a built-in spread spectrum function and the modulation switching frequency is ±fssFMW % around the set frequency fswx. The spread spectrum modulation frequency and the modulation width fssFMW can be programmable by the register SSFM [2:0] and SSFMW [1:0]. When SSFM [2:0] is set to 0, spread spectrum modulation is not applicable. When enable the SSFM function, all channels operate at the same modulation frequency ( $f_{SSEM}$ ). During SYNC operation, this function is disabled, so set SSFM[2:0] = 0.





#### **12 Protection Function**

12.1 Power On Reset (POR)

The BD18354MUF-M has a POR circuit monitoring the input power supply VREG5. When POR is detected, all internal circuits and logic registers will be initialized. The POR circuit's main purpose is internal logic initialized in POR condition by reset signal. Between the POR detection threshold and UVLO detection threshold by the VREG5 pin, internal register values will not be reset.

12.2 Under Voltage Lock Out (UVLO)

UVLO is a protection circuit that prevents IC malfunction at power-ON or power-OFF.

When the VIN pin voltage becomes VINUVD or less, the VREG5 pin voltage becomes VREG5UVD or less, or the VDRV7 pin voltage becomes V<sub>DRV7UVD</sub> or less, the PDRVx pin outputs high level to turn off external P-ch MOSFET. DC/DC is stopped and GLx outputs low level.

12.3 Thermal Shutdown (TSD)

In case of a TSD as Ti  $> 175$  °C (Typ), all the buck DC/DC converters will be disable immediately and all internal circuits and logic registers will be initialized. When TSD recovered at  $Ti < 150 °C$  (Typ), the DC/DC converters will be in the SPI state until start-up sequence trigger occurs.

#### 12.4 Over Current Protection (OCP)

When the CSx pin voltage becomes V<sub>CSOCPx</sub> or more, over current is detected and the GLx pin outputs low until the next switching cycle. Also, if OCP is detected 8 times under the condition that COMPx pin voltage exceeds V<sub>CSLOW</sub> + slope compensation voltage, the device will be in hiccup mode (automatic recovery switching off). In the hiccup mode, the PDRVx pin outputs high level to turn off the external P-ch MOSFET. DC/DC stops and GLx outputs low level. FAULT\_Bx outputs low level and outputs error detection. The device restart after hiccup time (t<sub>HICCUP</sub>) elapses. The OCP detection current  $({}_{\text{OCPx}})$  is set by the following formula.

$$
I_{OCPx} = \frac{V_{CSOCPx}}{R_{CSx}} \quad [A]
$$

Where:

 $V_{CSOCPX}$  is the OCP detection voltage set by the OCPSETx[1:0] register.  $R_{CSY}$  is a resistor connected to the CSx pin.

The OCP detection voltage (VcsocPx) is set by the following table.



#### **12 Protection Function - continued**

12.5 Short Circuit Protection (SCP)

When the anode of the LED is shorted to GND, the voltage between the SNSPx pin and the SNSNx pin can be monitored and protected by SCP.

When the voltage between the SNSPx pin and the SNSNx pin become VSNSxSCP or more, SCP is detected after SCP delay time (tscppLy). The detection voltage (V<sub>SNSxSCP</sub>) is set 330 mV.

When SCP is detected, the PDRV pin outputs high level to turn off the external P-ch MOSFET. DC/DC stops and GL outputs low level. FAULT\_B outputs low level and outputs error detection.

Restart after hiccup time (t<sub>HICCUP</sub>) elapses. If the anode of the LED is shorted to GND, the SCP is detected again and the operation is repeated. FAULT\_B holds low output until  $t_{FAULTBL}$  after restart.



Figure 18. Timing Chart (SCP)

When the anode of the LED is shorted to GND, the voltage between the SNSP pin and the SNSN pin may exceed the absolute voltage. It is recommended to insert a PNP transistor as shown below figure and clamp the voltage. Design to take full consideration of power dissipation of R<sub>SNSx</sub> and P-ch MOSFET.



Figure 19. PNP Clamp Setting Circuit

#### **12 Protection Function - continued**

12.6 Over Voltage Protection (OVP)

OVP is detected when the SNSPx pin voltage becomes  $V_{\text{OVPx}}$  or more. The detection voltage ( $V_{\text{OVPx}}$ ) is set by the following formula.



 $V_{OVPX} = OVPSET[3: 0] \times 2.18 + 34.8$  [V]



When OVP is detected, the PDRVx pin outputs high level to turn off the external P-ch MOSFET. DC/DC stops and GLx outputs low level. FAULT\_Bx outputs low level and outputs error detection.

OVP has hysteresis (VovPxHYS = 1.6 V typ), and when the SNSPx pin voltage becomes VovPx - VovPxHYS or less, DC/DC restarts. When the LED is open, OVP is detected again and the OVP detection operation is repeated.

When OVP is released and the voltage between the SNSPx pin and the SNSNx pin becomes VSNSxSG (LED Status Good Threshold Voltage) or more, FAULT\_Bx outputs high level. FAULT\_Bx holds low output until tFAULT\_BL elapses after OVP is released.



#### **12 Protection Function - continued**

12.7 External Over Voltage Protection (EOVP)

When EOVPx/SSU $\bar{x}$  = 0 (initial setting), OVP voltage can be set by dividing resistors R<sub>EOVPx1</sub>, R<sub>EOVPx2</sub> connected between DC/DC output and GND. LED open failure can also be detected by the OVP function. The detection voltage  $V_{\text{OUT EOVPx}}$  is set by the following formula.

$$
V_{OUT\_EOVPx} = \frac{R_{EOVPx1} + R_{EOVPx2}}{R_{EOVPx2}} \times V_{EOVPx} \quad [V]
$$

Where:

 $V_{EOVPx}$  is the external over voltage protection detect voltage = 2.50 V (Typ).

The timing chart for detection is the same as for OVP.



Figure 22. External OVP Setting Circuit

#### 12.8 Under Voltage Detection (UVD)

When EOVPx/SSUx = 1 UVD is detected when the SNSNx pin voltage become  $V_{\text{UVD}}$  or less.

The UVD detection voltage V<sub>UVD</sub> and the UVD release voltage V<sub>UVR</sub> set by BTBx register. If BTBx is set to "0" in the BTBx register, the UVD detection voltage V<sub>UVDx1</sub> = 0.6 V (Min). The UVD release voltage V<sub>UVRx1</sub> = 2.2 V (Max). If BTBx is set to "1" in the BTBx register, the UVD detection voltage V<sub>UVDx2</sub> = 13.6 V (Min). The UVD release voltage V<sub>UVRx2</sub> = 15.2 V (Max).

UVD is monitored when the voltage between the SNSPx pin and the SNSNx pin becomes V<sub>SNSxSG</sub> or more in the ON section of PWM dimming. After detection the internal counter starts. When the voltage between the SNSPx pin and the SNSNx pin becomes V<sub>SNSxSG</sub> or more in the ON section of PWM dimming, it counts up. When the total time reaches tuvp, the FAULT Bx outputs becomes Low.

After UVLO, TSD, SCP, OVP is released or after EN = H input, until t<sub>UVD</sub> has elapsed, UVD does not be detected.



Figure 23. UVD Setting Circuit

#### 12.8 Under Voltage Detection (UVD) - continued



Figure 24. Timing Chart (UVD)

When the LED is short-circuited during lighting in the Buck-Boost topology, etc., SCP operates at first and hiccup operation occurs, and UVD may be detected 20 ms (Typ) after the SCP detection release condition. In this case, the FAULT\_Bx signal will output FAULT\_Bx = L when SCP is detected, FAULT\_Bx = H when SCP is released, and FAULT\_Bx = L again when UVD is detected 20 ms later or later. FAULT\_Bx = L output is held until the UVD condition is released.

#### 12.9 External Under Voltage Detection (EUVD)

When EOVPx/SSUx = 0 setting, EUVD is enabled instead of UVD.

EUVD voltage can be set by dividing resistors  $R_{EOWPx1}$ ,  $R_{EOWPx2}$  connected between DC/DC output and GND. This function is effective when the SNSNx pin voltage = 7.1 V or less. The detection voltage ( $V_{\text{OUT_EUVDX}}$ ) is set by the following formula.

$$
V_{OUT\_EUVDx} = \frac{R_{EOVPx1} + R_{EOVPx2}}{R_{EOVPx2}} \times V_{EUVDx} \quad [V]
$$

Where:

 $V_{EUVDx}$  is the external under voltage detect voltage = 185 mV (Typ).

The settings and operation regarding BTBx and the timing chart for detection are the same as for UVD. When the state is shifted to the STAND-ALONE state with the CSB pin = "L" input held, it is recognized as the BTB1 register "0" setting when the SCL pin < 0.6 V, the BTB1 register "1" setting when the SCL pin > 2.2 V, the BTB2 register "0" setting when the SDA pin < 0.6 V, the SDA pin > 2.2 V, the BTB2 register is set to "1".


## **13 Outputs Abnormal Status (FAULT\_Bx)**

The following table summarizes the device's behavior under fault condition.

Abnormal detection / protection function

In BD18354MUF-M, the OCP and SCP faults can be configured to be a non-latched fault in OCPLATx, and SCPLATx register. If a fault is configured as non-latched, upon occurrence of the fault, the associated channel turns off. The channel performs a soft-start after expiration of a configurable fault timer and when the fault is cleared. In latched fault condition, the associated channel is turned off and remains off until the channel enable-bits are reprogrammed in the EN register.



*(Note)* The setting becomes effective after UVLO is released. V<sub>CSHIGH</sub> = V<sub>CSLOW</sub> + slope compensation voltage.

## **13 Outputs Abnormal Status (FAULT\_Bx) - continued**



*(Note)* The setting becomes effective after UVLO is released.

#### Protection setting table



" $x$ " –  $x = 1,2$  for channel.<br>"

"-" – This protection does not have this function.

"Status register" – If there are two registers, both registers are updated. This protection does not have effect on this output.

When POR or TSD is detected, it is not possible to detect other protection.

#### **14 A/D Monitor Channel Select**

The following table is A/D monitor setting table.

The data in register is updated to the newest data immediately when the new data is written. Do not set VMONSEL and read AD values at the same time.

Read AD values after VMONSEL setting is completed.

bit[3:0] VMONSEL[3:0]

VMON register is shared in for monitoring below node. This register should be programmed before reading VMON register when target node voltage is need.







## **15 State Machine**



Figure 26. State Machine

*(Note 1)* To avoid SPI communication malfunction, be sure to apply CSB = H when SPI communication control is not performed. *(Note 2)* During this SPI access, the state only transitions from the LIMP-HOME state to the SPI state. The register value is not updated. *(Note 3)* ACK\_ERR asserts high (ACK\_ERR = 1) when follower address did not ACK during I2C EEPROM read operation. ACK\_ERR is cleared when SWRST = 1 or FLTRST $\overline{x}$  = 1.



Table 3. State Machine Description

#### <span id="page-40-0"></span>**16 SPI Protocol and AC Electrical Characteristics**

This IC can be accessed via the SPI using the CSB, SCK, SI and SO pins as shown below.

- CSB Chip Select
- SCK Serial Clock
- SI Serial Data Input
- SO Serial Data Output



Figure 27. MCU Connection

Select the IC to be accessed by setting the CSB to low. Send the data based on the format as shown below figure. Data to be sent follow a MSB first 24-bit data format for write: 1-bit RW (read or write), 7-bit register address, 8-bit register data (to be written) and 8-bit CRC. The SPI can be accessed in daisy chain connection or parallel connection. There is no multiple bytes write/read feature. After each command, fix SI to low and CSB to high. SI data is output with 24 bits shift from SO. Pull



Figure 28. Data Format (Write)

Read command data format is sent as follows: 1-bit RW, 7-bit register address, fixed 0xFF for register data and 8-bit CRC. When CRC is OK (w\_crc\_ok = high) after the Read command as shown below, it is necessary to toggle CSB (low -> high -> low) to store the read data.

To output the data, it is necessary to send 24-bit High input data (Dummy Data).

MCU must calculate CRC using 0 as initial value.

For input data: use 16-bit data for calculation. 16-bit data = (RW, Address[6:0], Data[7:0])

For output data: use 15-bit data for calculation.

 $\le$ RDMODE = 0> 15-bit data = (Address[6:0], Data[7:0]) Not including MSB.

<RDMODE = 1> 15-bit data = (5-bit (blank data), Data0[7:0], Data1[1:0]) Not including MSB.



Figure 29. Data Format (Read)

## **SPI AC Timing**

SPI AC characteristics are as shown below.



Figure 30. SPI AC Timing

	Table 4. SPI AC Timing

Recommended Operation Condition (Unless otherwise specified  $V_{\text{IN}}$  = 13 V, Tj = -40 °C to +150 °C)



(Output load capacitance: 15 pF)



This IC has a CRC (cyclic redundancy check) function for detecting errors in the SPI communication. CRC for write command is calculated using RW bit, 6-bit register address and 8-bit register data and is calculated MSB first. Read output is calculated the same.

CRC formula is"  $x^8 + x^5 + x^4 + 1$ " which is translated as the circuit as shown below. Initial value of CRC is 0x00.



## Figure 31. CRC Circuit

NOTE (SPI Restrictions):

Command with the following input is not valid  $RW = 0$ , Address = 0x00, Data = 0x00, CRC = 0x00. SPI will not execute the read command it is treated as dummy and will only shift the input by 24-bit.

Example 1) Writing data  $Address = 0x14 (ADTRG)$ Data =  $0x80$  $CRC = 0xB4$ 



Figure 32. SPI Protocol of the 1 Byte Write

Example 2) Reading data (RDMODE = 1) Address = 0x1C (VMON) Data = 0xFF(dummy) CRC = 0x76 (MCU -> this device)

 $Read data = 0x05$ CRC = 0xF5 (this device -> MCU)



Figure 33. SPI Protocol of the 1 Byte Read

## **17 EEPROM Operation**

EEPROM can be used to store 8 sets of register setting using 4-kbit EEPROM size. MSEL pin voltage can be controlled to select which setting will be used by the device. EEPROM access is also available by setting the MODE pin. When MODE = H, EEPROM load is available after starting the device. When MODE = L, EEPROM load is available when WDT error is detected. Writing or updating EEPROM values is also available using the SPI Interface. EEPROM can be accessed using the SCL and SDA pins as show in the figure below. If EEPROM is not used, both the SDA pin and the SCL pin should be pulled up with 1 kΩ to the VREG5 pin.

SCL - Serial Clock for EEPROM Access

SDA - Serial Data for EEPROM Access



Figure 34. EEPROM and Device Connection

#### 17.1 EEPROM Load (The MODE Pin)





Figure 35. EEPROM Load Sequence

When you light the LED by EEPROM load access, follow the sequence below.

- $(1)$  Start the circuit with EN = H (To RESET state).
- ② When Reset is released, MSEL pin voltage is monitored by ADC after 25 µs to determine the EEPROM address setting.
- ③ EEPROM load will start and data from EEPROM is stored to internal register map of the device.
- ④ EEPROM load will finish after 2 ms and device will operate based on the loaded EEPROM data.

## 17.1 EEPROM Load (The MODE Pin) – continued

By monitoring the MSEL pin voltage, register setting number can be selected and load the data stored in the respective EEPROM address. For the data stored in each setting, alternate register address data and CRC data is stored. This is to make sure that correct data is loaded and stored to internal register map. When corresponding CRC data is NG and was detected twice, EEPROM load will stop and the state goes to STAND-ALONE.







EEPROM load will start by sending a dummy byte (start bit, 9 SCL cycles high, stop bit). After that, follower address will be sent followed by a write bit. The next byte will be address byte which indicates the start address for EEPROM load. The follower address will be sent again but R/W bit is now HIGH indicating read command to EEPROM. The SDA line will now be controlled by EEPROM and data byte will be sent to the device one-by-one. The sequential read protocol is displayed in the figure below and this protocol is automatically sent by the device.



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## 17.1 EEPROM Load (The MODE pin) – continued

## **EEPROM Access Parameters**

## **Follower Address**



## **Address Byte**

bit 7 bit 6 bit 5 bit 4 bit 3 bit 2 bit 1 bit 0

Address Byte[7:0]



## **Data Byte**

bit 7 bit 6 bit 5 bit 4 bit 3 bit 2 bit 1 bit 0 Data Byte[7:0]



## **17 EEPROM Operation – continued**

## 17.2 EEPROM Load (SPI Signal)

EEPROM Data can be updated by using the SPI Interface. The figure below shows the sequence on how to write or update data.



Figure 37. EEPROM Write Sequence

In writing or updating EEPROM values, follow the sequence below.

- $(1)$  Start the circuit with EN = H (To RESET state).
- ② When reset is released, state will go to the SPI operation. Update MSEL register to select which EEPROM address range will be updated.
- ③ Update EEPR register to H. This will enable write-protection to internal register map. Instead of storing the SPI write commands to register map, it will be automatically converted to I2C write command that will be sent to EEPROM.
- ④ EEPROM will be updated by the SPI Interface. The designated address is calculated automatically and the corresponding CRC data is also stored to the next address of the data.

The Write Protocol to update EEPROM values can be seen in the figure below. The device will start by sending the follower address followed by R/W = 0 bit to indicate write command. The address byte is the calculated address where the data will be stored. The data byte will be the same as the data sent through the SPI write command and the CRC for this data is automatically computed and will be written to the next EEPROM address after 25 µs. Bus Activity:



Figure 38. Byte Write Protocol

## **18 Register**

**Register MAP**(Address 0x00 to 0x20)



WO: Write Only, RO: Read Only, R/W: Read and Write

SWRST register reset condition is POR/TSD. All other registers reset condition is POR/TSD/SWRST. When writing a register value to the EEPROM be sure to write 0 for the SWRST register value.

*(Caution 1)* SWRST, FLTRSTx and ADTRG are "write only", and reset condition of SWRST is only "POR/TSD".

*(Caution 2)* EEPR, SLEEP and SWRST can only be updated by SPI (not affected by EEPROM load). *(Caution 3)* When writing a register value to the EEPROM be sure to write 0 for the SWRST register value.

## **Description of Registers**



The data in register is updated to the newest data immediately when the new data is written. Set these registers in initial setting.

bit[0] SWRST

SWRST register return '0' automatically. Hence, this register is "Write only". Set this register when you want to reset digital circuit. When writing a register value to the EEPROM be sure to write 0 for the SWRST register value. Writing 1 in the SWRST register will not work properly.

## Table 6. SWRST Operation



# bit[1] FLTBCNT<br>bit[2] FLTBCNT

**FLTBCNTEN** These register controls FAULT\_B output. If FLTBCNTEN = 0, FAULT\_B is controlled by error detection. If FLTBCNTEN = 1, FAULT\_B is Low when FLTBCNT = 0 and FAULT\_B is Hiz when FLTBCNT = 1.



## bit[4] SLEEP

This IC has sleep mode which stops internal clock, so this IC is in low "quiescent current" condition. This IC keeps register value when SLEEP = 1.





## bit[5] RDMODE

This register controls read protocol. If RDMODE = 1, it outputs read data (target address 8-bit + next address bit[1:0]). The detail of protocol can be referred in ["SPI Protocol"](#page-40-0) section.



Figure 39. RDMODE Operation

#### bit[6] WLOCK

DPWMx, ISETx and VMON registers are split into two registers (higher and lower byte). Normally, whenever a byte (higher or lower) is written, it will immediately be reflected in PWM dimming control. If WLOCK function is used, PWM dimming control will not be updated until the two bytes (higher and lower) are written. Note that it doesn't matter whether the higher or lower byte is written first.





Figure 40. WLOCK Function Example



The data in register is updated to the newest data immediately when the new data is written.

#### bit[4:0] FLTBEN[4:0]

FAULT\_B output enable setting



<b>FLTBENIXI</b>	Operation		
	Target protection is disabled in FAULT_B output. FAULT B is fixed 'H' (with Pull-up resistor).		
	Normal operation.		

Table 12. FLTBEN Assigned for Each Protection



bit[6] WDTEN

This register is "Watch Dog Timer" function enable. If WDTEN = 1, LIMP-HOME function is available by "Watch Dog Timer error" when state is "SPI operation".

Changing the WDTEN register setting after "Watch Dog Timer error" detection is prohibited.

#### Table 13. "Watch Dog Timer" Enable



## ●Address 0x02: ERRSET2 Protection Setting [Read/Write] Initial Value 0x1F



The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

bit[3:0] OVPSET1[3:0]

This register controls the OVP voltage threshold for CH1. (See ["Over Voltage Protection \(OVP\)"](#page-33-0).)





#### bit[5:4] OCPSET1[1:0] This register controls the OCP voltage threshold for CH1. (See ["Over Current Protection \(OCP\)"](#page-31-0).)



#### Table 15. OCP Voltage Setting

#### bit[6] SCP1MASK

The SCP function of CH1 is programmed by this register. When SCP1MASK = '0', the SCP function of CH1 is enabled, when SCP1MASK = '1', the SCP function of CH1 is masked.



#### bit[7] OCP1MASK

The OCP function of CH1 is programmed by this register. When OCP1MASK = '0', the OCP function of CH1 is enabled, when OCP1MASK = '1', the OCP function of CH1 is masked.





The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

bit[4] EOVP1/SSU1

When EOVP1/SSU1 = 0, the external OVP and UVD functions are enabled and the SSU function is disabled, when EOVP1/SSU1 = 1, the external OVP and UVD functions are disabled and the SSU function is enabled. (For details on "External [Over Voltage Protection \(EOVP\)"](#page-34-0) and ["Slow Startup"](#page-15-0).)





#### bit[5] OCPLAT1

The releasing function of over current protection is programmed by this register. If OCPLAT1 = '1', the OCPERR1 register doesn't become '0' until writing FLTRST1 = '1'. If OCPLAT1 = '0', The OCPERR1 becomes '0' by over current protection released. Set OCPLAT1 when OCPERR1 =  $0$ .





## bit[6] SCPLAT1

The releasing function of short circuit protection is programmed by this register. If SCPLAT1 = '1', the SCPERR1 register doesn't become '0' until writing FLTRST1 = '1'. If SCPLAT1 = '0', the SCPERR1 becomes '0' by short circuit error protection released.

Set SCPLAT1 when SCPERR1 = 0.





#### bit[7] FLTRST1

The error status registers are initialized by this register. If each protection is latched, its condition is released. For WDTERR, SPICRCERR and I2CCRCERR, either FLTRST1 or FLTRST2 can clear the error.



OVPERR1 and UVDERR1 are not reset.

#### ●Address 0x04: ERRSET4

This register is used to make setting of protection for CH2.

The setting procedure is the same as that for CH1 with Address set to 0x02.

●Address 0x05: ERRSET5

This register is used to make setting of protection for CH2.

The setting procedure is the same as that for CH1 with Address set to 0x03.



The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

bit[6:4] PWMDIV[2:0]

The PWM dimming frequency is programmed by this register.



#### bit[7] PPSEN

The PWM dimming phase is programmed by this register.





Figure 41. PWM Phase Shift Setting





The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting. If you want to change value during dimming, WLOCK function can be used.

ISET1H<br>bit[7:0]: bit[7:0]: ISET1[9:2] ISET1L bit[1:0]: ISET1[1:0]

LED average current is programmed by this register using the following formula.

Formula

$$
I_{LED1AVE} = \frac{V_{SNS1}}{R_{SNS1}} = \frac{V_{DCDIM1} - 0.2 \text{ V}}{12 \times R_{SNS1}} = \left(\frac{ISET1[9:0]}{1024} \times V_{FSRADC} - 0.2 \text{ V}\right) \times \frac{1}{12 \times R_{SNS1}}
$$

ISET1L

bit[7:4]: CAL1[3:0]

CAL1: Each channel has three calibration bits, which adds 2.75 mV of offset per bit (2.75 mV to 19.25 mV) to the slope low voltage.



Table 24. Slope Low Voltage Setting

●Address 0x09 to 0x0A: ISET2H, ISET2L

This register is used to make setting of LED current for CH2. The setting procedure is the same as that for CH1 with address set to 0x07 and 0x08



The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting. If you want to change value during dimming, WLOCK function can be used.

Initial Value 0 0 0 0 0 0 0 0

DPWM1H bit[7:0]: DPWM1[9:2]

DPWM<sub>1L</sub>

bit[1:0]: DPWM1[1:0]

LED average current in PWM is programmed by this register. When DPWM = 10'h000, PWM output is fixed low. For DPWM > 10'h000, the dimming ratio is calculated by the following formula.

$$
D_{PWMx} = \frac{DPWMx[9:0] + 1}{1024}
$$



●Address 0x0D to 0x0E: DPWM2H, DPWM2L

This register is used to make setting of PWM for CH2. The setting procedure is the same as that for CH1 with address set to 0x0B and 0x0C.



The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.





See ["SPI operation \(Multi phase Voltage output\)"](#page-96-0) for application examples.



The data in register is updated to the newest data immediately when the new data is written. Set these registers in initial setting.

The startup setting is enabled when CHON2 = CHON1 = 1.

VOUT output voltage is set by ISET1[9:0].

ISET2[9:0] setting is invalid.

bit[1:0] VMODEx

"Voltage regulation mode" for DC/DC is programmed by this register.





bit[3:2] BTBx

The internal UVD detection voltage of CHx is programmed by this register.





#### bit[5:4] SSUSET1[1:0]

This register controls the division factor for slow startup function of CH1. See ["Slow Startup"](#page-15-0) in description of blocks section for the details.

#### bit[7:6] SSUSET2[1:0]

This register controls the division factor for slow startup function of CH2. See ["Slow Startup"](#page-15-0) in description of blocks section for the details.



The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

bit[2:0] SSFM[2:0]

The modulation DC/DC switching frequency is programmed for all channel by this register.



#### Table 27. SSFM Modulation Setting

bit[4:3] SSFMW[1:0]

The modulation DC/DC switching frequency deviation is programmed for all channel by this register.





The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

bit[2:0] SSSET1[2:0]

This register controls the division factor for the switching frequency that will be used in soft start function of CH1. See ["Soft Start"](#page-26-0) in the description of blocks section for the details.

bit[5:3] SSSET2[2:0]

This register controls the division factor for the switching frequency that will be used in soft start function of CH2. See ["Soft Start"](#page-26-0) in the description of blocks section for the details.



The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

#### bit[1:0] CHONx

Each channel starts-up by this register. If CHONx = 1, LED dimming is available for CHx. CHONx = 0, LED dimming is not available for CHx. Protection such as "Over Current Protection", "Short Circuit Protection", "Over Voltage Protection" and "Under Voltage Detection" in the target channel is not available when CHONx  $= 0.$ 



## bit[5:4] PWMDIMx

This register is used to turn the PWM dimming function ON/OFF.

When PWMDIMx = 1, PWM dimming can be performed using the internal PWM duty set by the DPWMx[9:0] register or the external PWM duty input to the PWMDx pin.

Internal PWM duty and external PWM duty are OR controlled (H signal has priority).

When PWMDIM $x = 0$ , the internal PWM duty is set to 100 %.

#### Table 30. PWM Dimming Enable



#### Table 31. How to Dim by PWM





The data in register is updated to the newest data immediately when the new data is written. Set these register in initial setting.

bit[3:0] VMONSEL[3:0]

VMON register is shared in for monitoring below node. This register should be programmed before reading VMON register when target node voltage is need.



Figure 43. A/D System Structure



#### bit[4] ADMODE

There are two A/D converting modes.

When ADMODE = 1, A/D converter is operated automatically. Conversion frequency is controlled by an internal counter that monitors the inputs used in dimming (VIN, BINx, NTCx) for voltage derating. 1 cycle = 128 µs.

When ADMODE = 0, A/D converter is operated manually by ADTRG. A/D converter becomes sleep condition (low current consumption) after 1 conversion.





bit[7] ADTRG

A/D starts to convert the data selected by VMONSEL register after writing ADTRG = 1 during ADMODE = 0. This register will return to '0' after writing '1'. Updated data is available less than 15 µs. Issue the ADTRG command after soft start of each channel is completed.





The data in register is updated to the newest data immediately when the new data is written. See ["VIN Pin, NTCx Pin and BINx Pin Dimming Setting"](#page-21-0) for the details.

- bit[1:0] NTCGAIN1[1:0] The thermal derating gain is set by this register.
- bit[3:2] BINSEL1[1:0] The value from the BIN table is set by this register.
- bit[5:4] VINDGAIN1[1:0] The input voltage derating gain is set by this register.
- bit[7:6] VINDSET1[1:0] The input voltage derating start voltage is set by this register.



The data in register is updated to the newest data immediately when the new data is written. See ["VIN Pin, NTCx Pin and BINx Pin Dimming Setting"](#page-21-0) for the details.

bit[7:0] NTCSET1[7:0]

The NTC start voltage is set by this register.

#### ●Address 0x17 to 0x18: NTCVINGAIN2 and NTCSET2

These registers are for voltage derating setting of CH2 and has same function as address 0x15 and 0x16.





The data in register is updated to the newest data immediately when the new data is written. For CURLIMENx see ["Rush Current Limit Drive Circuit"](#page-17-0) for detail.

bit[4:2] ISLPx[2:0]

The slope compensation peak voltage is set by this register.

Table 35. CHx Slope Compensation Peak Voltage Setting



bit[5] CURLIMEN1<br>bit[6] CURLIMEN2

CURLIMEN2





The register data is updated to the newest data immediately when the data are updated by A/D converting.

VMONH<br>bit[7:0] VMONL

bit[1:0]: VMON[1:0]

**VMON[9:2]** 

This register is used for monitoring Thermal, V<sub>IN</sub>, V<sub>SNSNx</sub>, V<sub>ISNSx</sub>, V<sub>BINx</sub>, V<sub>NTCx</sub>, V<sub>MSEL</sub> or V<sub>INDIM</sub> node.

This operation is programmed by VMONSEL register. This data is divided into two register address. If all of 10bit data is required during SPI read, RDMODE function is available.

Formula 1 for thermal sensor voltage



Formula 2 for external input pin nodes

Monitor voltage 1 [V] = "X" x (VMON + 1) / 1024

 $V_{\text{IN}}$ : "X" = 77.5,  $V_{\text{SNSNx}}$ : "X" = 75,  $V_{\text{ISNSx}}/V_{\text{NTCx}}$ : "X" = 2.5,  $V_{\text{BINx}}/V_{\text{MSEL}}$ : "X" = 5.0,  $V_{\text{INDIM}}$ : "X" = 10.



The register data is updated to the newest data immediately when the data (one or more error) is detected.

bit[1:0] ERRDETx

This register is error status each channel.





## bit[2] UVLO

This register is error status for UVLO.

Table 38. UVLO



#### bit[5] I2CCRCERR

This register is error status for I2C CRC. This error is detected when two times I2C CRC error is detected.





#### bit[6] SPICRCERR

This register is error status for the SPI CRC. If CRC error is detected, this register becomes 1. This register becomes 0 by FLTRSTx = 1. If CRC error occurred to the SPI command sent after to sending FLTRSTx, this will not be detected, for more details refer to error sequence for "SPI CRC error".

## Table 40. "SPI CRC" Error Status



#### bit[7] WDTERR

This register is error status for "Watch Dog Timer". If "Watch Dog Timer error" is detected, this register becomes 1. This register becomes 0 by FLTRSTx = 1.

#### Table 41. "Watch Dog Timer" Error Status





The register data is updated to the newest data immediately when the data ("Over Voltage Error", "Under Voltage Error", "Short Circuit Protection", "Over Current Protection") is detected.

## bit[0] OVPERR1

```
bit[4] OVPERR2
```
This register is "Over Voltage error" status for CHx. OVPERRx becomes "1" and FAULT\_Bx becomes "0" when "CHx Over Voltage" is detected. When detecting, this status register will detect immediately but during release, there is 20 ms internal counter where PWMx = H (when PWM dimming H control) and SGx = H (when V<sub>SNSxAVE</sub> > V<sub>SNSxSG</sub>) before OVPERRx returns to "0" and FAULT\_Bx returns to normal "1".

#### Table 42. "Over Voltage Protection" Error Status



## bit[1] UVDERR1

#### bit[5] UVDERR2

This register is "Under Voltage Detection" status for CHx. UVDERRx becomes "1" and FAULT\_Bx becomes "0" when "CHx Under Voltage" is detected. This protection is only possible to detect after 20 ms internal counter where CHONx = H, PWMx = H (when PWM dimming H control) and SGx = H (when  $V_{\text{SNSAVE}}$  > V<sub>SNSxSG</sub>) and soft start is already finished (SSENDx = H). During release, UVDERRx returns to "0" immediately at PWMx = H and FAULT Bx returns to normal "1".





bit[2] SCPERR1<br>bit[6] SCPERR2

SCPERR2

This register is "Short Circuit Protection error" status for CHx. SCPERR1 becomes "1" and FAULT\_Bx becomes "0" when "CHx Short Circuit" is detected. There is a 50 µs internal counter when detecting SCP. After SCP is detected, hiccup operation starts repeatedly every 40 ms. When there is no longer Short Circuit error, there is 20 ms release time before SCPERRx returns to "0" and FAULT\_Bx returns to normal "1".

Table 44. "Short Circuit Protection" Error Status

<b>SCPERRX</b>	Status
	Normal
	Detects CHx Short Circuit Protection

#### bit[3] OCPERR1<br>bit[7] OCPERR2 OCPERR2

This register is "Over Current Protection" status for CHx. OCPERRx becomes "1" and FAULT\_Bx becomes "0" when "CHx Over Current" is detected. This protection is detected when OCPx is detected eight times and the device enters hiccup operation.

After hiccup time elapses, there is 20 ms internal counter for release time before OCPERRx returns to "0" and FAULT\_Bx returns to normal "1".







The data in registers is updated to the newest data immediately when the new data is written.

bit[2:0] MSEL[2:0]

This register is use for selecting access to each EEPROM address range.



 $T(t)$   $\alpha$ ,  $\alpha$ 

#### bit[3] PAGEWREN

This register is used to enable EEPROM page write.



#### bit[5:4] WRSEL[1:0]

This register is used for the selection of EEPROM write options.

Table 48. EEPROM Write Mode Select

<b>WRSEL[1:0]</b>	<b>Status</b>
	No writing
	Byte write mode
	8 bytes page write mode
	16 bytes page write mode

bit[6] EEP\_LOAD

This register is used to select EEPROM operation.



#### bit[7] EEPR

This register is used to enable access to EEPROM.





#### Table 51. EEPROM Control Registers



## **Writing procedure**

(ex.1) Write to model 2 with Byte write option.

Data to be written to EEPROM is written to register map.

 $0x20 = 91$  (EEPR = 1, EEP\_LOAD = 0, WRSEL = 1, PAGEWREN = 0, MSEL = 1): Byte write command.

 $0x20 = 00$  (EEPR = 0, EEP\_LOAD = 0, WRSEL = 0, PAGEWREN = 0, MSEL = 0): Return to the SPI control.

(ex.2) Write to model 3 with 16byte Page write option.

Data to be written to EEPROM is written to register map.  $0x20 = B2$  (EEPR = 1, EEP\_LOAD = 0, WRSEL = 3, PAGEWREN = 0, MSEL = 2): Set write options and models.  $0x20 = BA$  (EEPR = 1, EEP\_LOAD = 0, WRSEL = 3, PAGEWREN = 1, MSEL = 2): Page write command.  $0x20 = 00$  (EEPR = 0, EEP\_LOAD = 0, WRSEL = 0, PAGEWREN = 0, MSEL = 0): Return to the SPI control.

#### **Loading procedure**

0x20 = C0 (EEPR = 1, EEP\_LOAD = 1, WRSEL = 0, PAGEWREN = 0, MSEL = 0): Data load command. 0x20 = 80 (EEPR = 1, EEP\_LOAD = 0, WRSEL = 0, PAGEWREN = 0, MSEL = 0): Return to EEPR standby state.  $0x20 = 00$  (EEPR = 0, EEP\_LOAD = 0, WRSEL = 0, PAGEWREN = 0, MSEL = 0): Return to the SPI control.

## **Operation Sequence**

**1 Start-up & Turn-off Sequence**

**1.1 Normal Start-up (No SPI Communication, EN Pin Control Start-up)**



Figure 44. Start-up Sequence for EN Pin Control

When you light the LED by EN pin control, follow the sequence below.

- ① Start the circuit with EN = H (To RESET state).
- ② Data loading starts from EEPROM after VREG5 UVLO is released. (To EEPROM operation state).
- ③ After loading is completed, each channel starts operation by EEPROM setting.
- ④ After turning off VREG5 with EN = L, go to standby state (To STANDBY state).

**1.2 Normal Start-up (No SPI Communication, VIN Start-up)**



Figure 45. Start-up Sequence for VIN Pin Control

When you light the LED by VIN pin control, follow the sequence below.

- ① Circuit start after VIN UVLO is released (To SPI operation state).
- ② Data loading starts from EEPROM after VREG5 UVLO is released.
- $\textcircled{3}$  After loading is completed, each channel starts operation by EEPROM setting.<br>  $\textcircled{4}$  Enter standby state after VIN UVI O is detected (To STANDBY state)
- Enter standby state after VIN UVLO is detected (To STANDBY state).

## **1.3 STAND-ALONE Start-up (EN = H, MODE = L, CSB = L)**



## Figure 46. Start-up Sequence for STAND-ALONE

When you light the LED by STAND-ALONE, follow the sequence below.

- $\overrightarrow{1}$  Start the circuit with EN = H (To RESET state)<br>
2 Start of 0.8 ms count since CSB = L, after VRE
- $\overline{2}$  Start of 0.8 ms count since CSB = L, after VREG5 UVLO is released (To SPI operation state).<br>  $\overline{3}$  Start operation in STAND-ALONE mode after 0.8 ms (To STAND-ALONE state).
- $\textcircled{3}$  Start operation in STAND-ALONE mode after 0.8 ms (To STAND-ALONE state).<br>  $\textcircled{4}$  Enter standby state with EN = L (To STANDBY state).
- Enter standby state with  $EN = L$  (To STANDBY state).

**1.4 Normal Start-up (SPI Operation)**



Figure 47. Start-up Sequence for Normal Operation

When you light the LED by general SPI control, follow the sequence below.

- ① VREG5 UVLO release.<br>② Turn on each channel b
- $\textcircled{2}$  Turn on each channel by setting CHONx = 1.<br> $\textcircled{3}$  Each channel is turned off by setting CHONx
- $\textcircled{3}$  Each channel is turned off by setting CHONx = 0.<br>
4 Operation off with VIN UVLO detection.
- ④ Operation off with VIN UVLO detection.



Figure 48. Sequence for SLEEP Mode

When you use SLEEP mode by the SPI control, follow the sequence below.

- 
- $\overline{10}$  CHONx = 0, this IC stop lighting and go "STANDBY" state.<br>
2 SLEEP = 1, internal oscillator stops. (Low quiescent curren<br>
3 SLEEP = 0, internal oscillator starts.  $SLEEP = 1$ , internal oscillator stops. (Low quiescent current by stopping internal clock)
- $SLEEP = 0$ , internal oscillator starts.
- $\widetilde{A}$  CHONx = x, this IC starts lighting and go "LED ACTIVE" state.

## **Operation Sequence – continued**

## **2 Error Sequence**

**2.1 Error Sequence for "CRC Error"**



- ① CRC error is detected when data sent does not match the CRC value in the SPI command. This mismatch can be caused by wrong data or noise in the SPI line. Write operation is not executed in the IC. Target register is not updated. In this case, CRC error status register is updated to H. Protection is latched automatically, sending the SPI command with correct CRC does not clear CRCERR status register.
- ② MCU sends read command to status registers to confirm CRC status register.
- ③ MCU sends FLTRSTx and dummy SPI (data 0x00) to release the status register.

## **SPI input WDTERR register CSB FLTRSTx register SO WDT counter** CRC NG **WDTEN register**  $\begin{pmatrix} 1 \end{pmatrix}$  (3) (4  $\binom{2}{2}$ **State** "SPI" "LIMP-HOME" "SPI"  $\binom{3}{}$ No activity in the SPI > 0.4 s

## **2.2 Error Sequence for "WDT Error"**

① Watch Dog Timer starts to count at SPI state. When there is no "CRC OK" detected in more than 0.4 s, IC detects WDT error.

Figure 50. WDT Error Detection

- ② WDT is detected, it sets the corresponding status register WDTERR to H and state changes from SPI to LIMP-HOME.
- ③ MCU sends read command to status register to confirm WDT status. This event releases LIMP-HOME mode.
- ④ WDT detection is latches automatically, MCU must send FLTRSTx to clear the WDTERR status register and FAULT\_Bx output.
## **Operation Sequence – continued**

#### **3 A/D Control Sequence**

This IC can control A/D monitoring mode by ADMODE register. When ADMODE is H, ADC is used for BINx, VIN and NTCx derating. When ADMODE is L, ADC can be operated manually.



#### **3.1 ADMODE = 1 (Auto Mode)**

Figure 51. A/D Control (ADMODE = 1)

- ① Automatic ADC Monitoring only operates when CHON output of either channel is turned on at ADMODE = H. CHON is enabled by writing using SPI, update by EEPROM load or by going to "STAND-ALONE" state. Whenboth ADMODE and either CHON channel are H, voltage from the BINx, VIN and NTCx pins is read for one time. This will be used to compute for the first ISETDx value which will be the reference value for slow startup or SSDAC function.
- ② After the first calculation is finished, ISETDx is updated and either slow startup or SSDAC operates based on the initial status of SSUx pin. DT\_ISETDx\_OD increments by 1 until it reached the value of calculated ISETDx. The value is updated even during increment.
- ③ The automatic ADC monitoring continues but this time, only the VIN and NTCx pins will be monitored repeatedly. The interval between ADC monitoring is 25.6 µs while the interval of updating ISETDx output is 128 µs. When the pin voltage is changed, calculated ISETDx value will also change based on the derating formula and the result is reflected to DT\_ISETDx\_OD output.
- ④ Register settings for derating (VINDSETx, NTCSETx, VINDGAINx and NTCGAINx) can also be update if SPI access is available. New value of ISETDx is then calculated and reflected on next update timing. The output DT\_ISETDx\_OD is connected to DAC which is then connected to the LED driver to control the LED current.

## **3. A/D Control Sequence – continued**





Figure 52. A/D Control (ADMODE = 0)

- ① In order to monitor the pin voltage by ADC, VMONSEL register should be updated by SPI. For example, for VIN set VMONSEL to 4'h0 to enable monitoring at the VIN pin. A/D starts to convert by ADTRG = 1. The value is stored to VMON register which can be read by SPI.
- ② ADC converter takes around 11 µs to finish conversion. VMON register is available after 12 µs (include margin). SPI read is sent to confirm value of VMON register.

### **Typical Performance Curves**



Figure 53. VIN Stand-by Circuit Current vs VIN Pin Voltage Figure 54. VIN Sleep Circuit Current vs VIN Pin Voltage







Figure 55. VIN Circuit Current vs VIN Pin Voltage Figure 56. VIN UVLO Threshold Voltage vs Temperature





Figure 57. VDRV7 UVLO Threshold Voltage vs Temperature Figure 58. VREG5 UVLO Threshold Voltage vs Temperature



Figure 59. VREG5 POR Threshold Voltage vs Temperature Figure 60. VDRV7 Reference Voltage vs Temperature



 $I_{VDRV7}$  = No load

(Unless otherwise specified  $V_{\text{IN}}$  = 13 V, Ti = 25 °C)





**Datasheet** 

OCPSETx[1:0] = 3

(Unless otherwise specified  $V_{\text{IN}}$  = 13 V, Ti = 25 °C)



ISETx[9:0] = 552









Figure 69. Hiccup Time vs Temperature Figure 70. SNSNx Voltage vs Temperature  $ISETx[9:0] = 901$ , VMODEx = 1











Figure 73. PDRVx Output Low Voltage vs SNSPx Pin Voltage Figure 74. Switching Frequency Setting vs Temperature



 $R_{\text{RT}} = 47 \text{ k}\Omega$ , FRT[3:0] = 5 (initial)



Figure 75. Switching Frequency Setting vs Temperature  $R_{RT}$  = 47 kΩ, FRT[3:0] = 15



Figure 76. Switching Frequency Setting vs Temperature  $R_{RT}$  = 7.5 kΩ, FRT[3:0] = 5 (initial)









Figure 85. Internal Oscillator Frequency vs Temperature Figure 86. A/D Full Scale Reference Voltage vs Temperature





Figure 87. SNSPx Input Current vs Temperature Figure 88. SNSNx Input Current vs Temperature

## **Application Typical Waveforms**

[\(1 SPI Operation \(CH1: Boost CH2: Boost Voltage Output\)\)](#page-92-0)



Figure 91. CH1 External Over Voltage Protection Detect External OVP setting voltage = 55.6 V LED anode connection open detect The PWMD1  $pin = H$ 

Figure 92. CH1 External Over Voltage Protection Release External OVP setting voltage = 55.6 V LED anode connection open release The PWMD1  $pin = H$ 

# **Application Typical Waveforms - continued**

[\(1 SPI Operation \(CH1: Boost CH2: Boost Voltage Output\)\)](#page-92-0)





## **Application Typical Waveforms - continued**

[\(1 SPI Operation \(CH1: Boost CH2: Boost Voltage Output\)\)](#page-92-0)









Figure 100. CH2 Over Current Protection Release IOCP2 = 6.25 A setting (OCPSET2[1:0] = 1)

(2 STAND-ALONE [Operation \(CH1: SEPIC CH2: Boost to VIN\)\)](#page-94-0)





Figure 104. CH1 External Over Voltage Protection Release External OVP setting voltage = 55.6 V LED anode connection open release

(2 STAND-ALONE [Operation \(CH1: SEPIC CH2: Boost to VIN\)\)](#page-94-0)



Figure 105. CH1 Under Voltage Detection Detect LED anode short to GND detect

Figure 106. CH1 Under Voltage Detection Release LED anode short to GND release

Figure 108. CH2 OFF (Boost to VIN 4 LEDs Drive)  $I_{LED2} = 1.06$  A setting



Figure 107. CH2 ON (Boost to VIN 4 LEDs Drive)  $I_{LED2} = 1.06$  A setting

SW2 20 V/div

SNSP1 20 V/div

ILED<sub>2</sub> 500 mA/div

EN 5 V/div

# **Application Typical Waveforms - continued**

(2 STAND-ALONE [Operation \(CH1: SEPIC CH2: Boost to VIN\)\)](#page-94-0)



Figure 109. CH2 External Over Voltage Protection Detect External OVP setting voltage = 55.6 V LED anode connection open detect

Figure 110. CH2 External Over Voltage Protection Detect External OVP setting voltage = 55.6 V LED anode connection open release







SW2 20 V/div

FAULT\_B2 5 V/div

ILED2 1 A/div

SNSP2 20 V/div

**Datasheet** 

## **Application Typical Waveforms - continued**

[\(3 SPI Operation \(Multi Phase Voltage Output\)\)](#page-96-0)





Figure 116. Multiphase Output  $I_{\text{OUT}} = 0.1$  A to 2.0 A transient

(4 [STAND-ALONE Operation \(Multi Phase Voltage Output\)\)](#page-98-0)





Figure 120. Multiphase Output  $I_{\text{OUT}} = 0.1$  A to 2.0 A transient

## **Application Typical Waveforms - continued**

(5 EEPROM Operation (CH1: Boost with PWM Dimming, CH2: [Boost with Rush Current Limit Function\)\)](#page-100-0)





Rush Current Limit Function: ON (CURLIMEN2 = 1) Change LED number 8 LEDs to 12 LEDs

## **Application Examples**

### <span id="page-92-0"></span>**1 SPI Operation (CH1: Boost CH2: Boost Voltage Output)**

 $VIN = 8 V$  to 18 V DC/DC Switching Frequency = 399 kHz  $I_{OCP}$  = 6.25 A External OVP Setting Voltage = 55.6 V  $ADMODF = 0$ 

CH1: Current output LED = 8 series,  $Vf = 3.0 V$  (Typ),  $3.5 V$  (Max) LED Current = 1.04 A (= 166.6 mV / 0.16 Ω), 10 % PWM dimming (DPWM1[9:0] = 102) When PWMDIM1 = 1 and PWMD1 pin = H, 100 % PWM Dimming operation. When PWMDIM1 = 1 and PWMD1 pin = L, 10 % PWM Dimming operation.

CH2: Voltage output (VMODE2 = 1)  $V_{OUT} = 48 \text{ V}$  (ISET2[9:0] = 655)

This is the basic circuit for SPI operation. CH1 is boost LED driver configuration and CH2 is boost voltage output configuration. Registers not mentioned are initial settings (register values can be changed). When a communication error occurs, the STAND-ALONE operation is performed, and the PWMD1 pin = "H" to turn on the LED for CH1, and the PWMD2 pin = "L" to stop the voltage output for CH2. By connecting an EEPROM as an option, the register settings at the time of a communication error can be road from the EEPROM.



## **1 SPI Operation (CH1: Boost CH2: Boost Voltage Output) - continued**

Recommended Parts List



## **Application Examples - continued**

### <span id="page-94-0"></span>**2 STAND-ALONE Operation (CH1: SEPIC CH2: Boost to VIN)**

VIN = 8.5 V to 18 V DC/DC Switching Frequency = 399 kHz  $I_{OCP}$  = 6.25 A External OVP Setting Voltage = 55.6 V LED = 4 series,  $Vf = 3.0 V$  (Typ), 3.5 V (Max)

CH1: Current output LED Current = 1.06 A (= 191.1 mV / 0.18 Ω)

CH2: Current output LED Current =  $1.06$  A (= 191.1 mV / 0.18 Ω, PWM dimming 20 %)

This is a basic circuit for turning on LEDs under STAND-ALONE control, with CH1 in SEPIC configuration and CH2 in boost to VIN configuration. The registers are initial settings for STAND-ALONE control (The register values cannot be changed).



## **2 STAND-ALONE Operation (CH1: SEPIC CH2: Boost to VIN) - continued**

Recommended Parts List



## **Application Examples - continued**

#### <span id="page-96-0"></span>**3 SPI Operation (Multi Phase Voltage Output)**

 $VIN = 8 V to 18 V$ DC/DC Switching Frequency = 399 kHz MULTIP = 1, VMODE1 = VMODE2 = 1, SCP1MASK = SCP2MASK = 1, CHON1 = CHON2 = 1  $ADMODE = 0$  $V_{OUT} = 48 V (ISET1[9:0] = 655)$  $I_{\text{OUT}} = 1.0 \text{ A}$ ,  $I_{\text{OCP}} = 6.25 \text{ A}$ External OVP Setting Voltage = 55.6 V

This is a basic circuit for multiphase voltage output under SPI control. Registers not mentioned are initial settings. (Register values can be changed.)

When MULTIP = 1, COMP1 = COMP2 is shorted inside the IC.

The output voltage setting depends on the CH1 setting, but both CH1 and CH2 should be set the same.

The ISLP setting should be the same. CLIMEN function does not work.

Do not use PWM dimming.

When a communication error occurs, STAND-ALONE operation is performed and voltage output is stopped because the PWMDx pin = "L". By connecting EEPROM as an option, the register settings at the time of communication error can be read from EEPROM.



## **3 SPI Operation (Multi Phase Voltage Output) - continued**

Recommended Parts List



### **Application Examples - continued**

#### <span id="page-98-0"></span>**4 STAND-ALONE Operation (Multi Phase Voltage Output)**

VIN = 8.5 V to 18 V DC/DC Switching Frequency = 399 kHz  $V_{\text{OUT}} = 39.7 \text{ V}$ ,  $I_{\text{OUT}} = 1.0 \text{ A}$ ,  $I_{\text{OCP}} = 6.25 \text{ A}$ External OVP Setting Voltage = 55.6 V

This is a basic circuit for multiphase boost voltage output with STAND-ALONE control. The registers are initial settings. (Register values cannot be changed.)

In this application, the power components generate more heat when the input voltage is low.

Final thermal design decisions should be made after careful consideration and evaluation at worst case by the customer. The spread spectrum function operates at a frequency of  $\pm 5$  % (Typ) of the set frequency fsw in a STAND-ALONE setting. Refer to the following for the VOUT calculation formula under CV mode and STAND-ALONE conditions.

$$
V_{OUT} = \left(\frac{V_{SNS100\%}}{R_{O1}} - I_{SNSN\_HSS} \times 2\right) \times R_{O2} + V_{SNS99.8\%}
$$

 $V_{SNS99.8\%} = 0.1911$  [V]

 $I_{SNSN HSS} = 1.1 \times V_{SNSN} + 14$  [µA]



## **4 STAND-ALONE Operation (Multi Phase Voltage Output) - continued**

Recommended Parts List



### **Application Examples - continued**

#### <span id="page-100-0"></span>**5 EEPROM Operation (CH1: Boost with PWM Dimming, CH2: Boost with Rush Current Limit Function)**

 $VIN = 8 V to 18 V$ DC/DC Switching Frequency = 399 kHz  $I_{OCP}$  = 6.25 A  $ADMODE = 0$ Data load from EEPROM (Data set 2)

CH1: Boost Current Output LED = 16 series,  $Vf = 3.0 V$  (Tvp),  $3.5 V$  (Max) LED Current = 1.04 A (= 166.6 mV / 0.16 Ω), 10 % PWM dimming (DPWM1[9:0] = 102) OVP detection voltage =  $67.50$  V (EOVP1/SSU1 = 1, OVPSET1 $[3:0]$  = 15)

CH2: Boost Current Output (Rush Current Limit Function: ON) LED = 12/8 series,  $Vf = 3.0 \text{ V}$  (Typ), 3.5 V (Max) LED Current = 1.04 A (= 166.6 mV / 0.16  $\Omega$ ), Rush Current Limit Function: ON (CURLIMEN2 = 1) OVP detection voltage =  $50.06$  V (EOVP2/SSU2 = 1, OVPSET2[3:0] =  $7$ )

This is a basic circuit to turn on LEDs with EEPROM operation; CH1 is boost configuration and CH2 is boost to VIN configuration. Registers not mentioned are initial settings. (Depends on the EEPROM data to be loaded) Starts up by reading register settings from the address selected by the MSEL pin voltage. Lights off when a communication error occurs (because PWMD1 = PWMD2 = L). 8 different lighting conditions can be supported on the same board design by changing the MSEL pin voltage (limited to within the register setting range).



## **5 EEPROM Operation (CH1: Boost with PWM Dimming, CH2: Boost with Rush Current Limit Function) - continued**

Recommended Parts List



## **Application Parts Selection Method (Boost Mode LED Driver Application)**

Refer to [Application Examples 1 SPI Operation \(CH1: Boost](#page-92-0) Output). **A constant setting sheet is available. Contact ROHM directly.**



### **Application Parts Selection Method (Boost Mode LED Driver Application) - continued**

#### **1 Switching Frequency Setting**

The switching frequency of the DC/DC can be set by the resistor RRT connected to the RT pin and the register FRT[3:0]. Design value: Switching Frequency = 399 kHz (FRT[3:0] = 5)

$$
f_{SW} \approx \frac{(FRT[3:0]+1)\times k}{R_{RT}} = \frac{(5+1)\times k}{47 k\Omega} \approx 399
$$
 [kHz]

 $k = 3125 \times 10^6$ 

#### **2 Derivation of Input Peak Current IL\_MAX (ISETx[9:0] = 901)**

2.1 Calculation of Output Voltage  $(V<sub>OUT</sub>)$ 

BOOST Setting:

$$
V_{OUT} = V_{f\_{LED}} \times N + V_{SNSXAVE87\%H} + R_{ON\_PWMFET} \times I_{LED}
$$

$$
= 3.0 \times 8 + 0.1666 + 0.2 \times 1 \approx 24.4
$$
 [V]

Where:



2.2 Calculation of DC/DC Switching Duty (Dsw)

$$
D_{SW} = \frac{V_{OUT} - V_{IN}}{V_{OUT}} = \frac{24 V - 13 V}{24 V} \approx 0.458
$$

2.3 Calculation of Output Current (ILED)

$$
I_{LED} = \frac{V_{SNSXAVE87\%H}}{R_{SNS}} = \frac{0.1666}{0.16} \approx 1.04
$$
 [A]

2.4 Calculation of Input Peak Current (IL\_MAX)

$$
I_{L\_MAX} = I_{L\_AVE\_MAX} + \frac{1}{2} \Delta I_{L\_MAX} = 3.90 + 0.84 = 4.74
$$
 [A]

$$
I_{L\_MIN} = I_{L\_AVE\_MIN} - \frac{1}{2} \Delta I_{L\_MAX} = 1.48 - 0.84 = 0.64
$$
 [A]

$$
I_{L\_AVE\_MAX} = \frac{V_{OUT\_MAX} \times I_{LED}}{\eta \times V_{IN\_MIN}} = \frac{28 V \times 1.4}{0.9 \times 8} \approx 3.90
$$
 [A]

$$
I_{L\_AVE\_MIN} = \frac{V_{OUT\_MIN} \times I_{LED}}{\eta \times V_{IN\_MAX}} = \frac{24 V \times 1A}{0.9 \times 18} \approx 1.48
$$
 [A]

$$
\Delta I_{L\_MAX} = \frac{V_{IN}}{L} \times \frac{(V_{OUT} - V_{IN})}{V_{OUT}} \times \frac{1}{f_{SW\_MIN}}
$$
  
= 
$$
\frac{14 V}{10 \mu H} \times \frac{(28 V - 14 V)}{28 V} \times \frac{1}{360 kHz} \approx 1.68
$$
 [A]

Where:



- 2.4 Calculation of Input Peak Current (IL\_MAX) continued
	- ●Assign minimum input voltage for calculation.

<sup>●</sup>BD18354MUF-M adopts current mode DC/DC converter control. When IL\_MIN is positive, it becomes to be in the consecutive modes, and it will be in the discontinuity mode when IL\_MIN is negative. Feedback characteristics are easy to become insufficient in the discontinuous mode, and responsiveness turns worse, and a switching waveform pattern becomes irregular, and stability is easy to turn worse. Therefore, it is sufficient validation of feedback characteristics are recommended.

<sup>●</sup>η (efficiency) is calculated as 90 %.

## **Application Parts Selection Method (Boost Mode LED Driver Application) - continued**

#### **3 Over Current Protection Setting**

Select R<sub>cs</sub> (resistance for over current detection) to realize below. Design value: Over current detection = 6.25 A (OCPSETx[1:0] = 1)

$$
I_{OCP\_MIN} = \frac{V_{CSOCP\_MIN}}{R_{CS\_MAX}} > I_{L\_MAX}
$$
 [A]  

$$
I_{OCP\_MIN} = \frac{V_{CSOCP\_MIN}}{R_{CS\_MAX}} = \frac{0.132}{0.02424} \approx 5.45 > 4.74
$$
 [A]

Where:

 $I_{OCP~MIN}$  is the minimum over current detection current.  $V_{CSOCP~MIN}$  is the minimum over current detection voltage (OCPSETx[1:0] = 1 = 150 mV).

Set a sufficient margin in consideration of the variation of the inductor.

### **4 Inductor Selection**

For the purpose of stabilizing current mode DC/DC converter operation, adjustment of L value within the following condition is recommended.

$$
L > \frac{(V_{OUT} - V_{IN}) \times R_{CS\_MAX}}{\Delta ISLP_{MIN} \times f_{SW\_MIN} \times 2}
$$
  

$$
L > \frac{(28 - 8) \times 24.24 \text{ m}\Omega}{200 \text{ mV} \times 360 \text{ kHz} \times 2} \approx 3.4
$$
 [µH]

Where:<br>*AISLP<sub>MIN</sub>*  $\Delta ISLP_{MIN}$  is the minimum slope compensation setting (ISLPx[1:0] = 4 = 235 mV).<br>  $f_{SW MIN}$  is the minimum switching frequency (FRT[3:0] = 5 = 399 kHz). is the minimum switching frequency (FRT $[3:0] = 5 = 399$  kHz).

### **Application Parts Selection Method (Boost Mode LED Driver Application) - continued**

#### **5 OVP (LED Open) Detection Voltage Setting**

The LED open detection voltage setting can be made with OVPSETx[3:0] register or with the resistor value connected to the SSUx pin.

See ["Description of Blocks 12.6 Over Voltage Protection \(OVP\)"](#page-33-0) for details on the OVPSETx[3:0] register setting. This section describes how to set OVP using external resistors. The LED open detection voltage needs higher voltage setting than overshoot of output voltage at start up to avoid start up failure. Further, output voltage at the time of LED open detection (V<sub>OUT EOVP</sub>) is calculable as shown below by setting R<sub>E11</sub> and R<sub>E12</sub>. Design value: External over voltage detection = 55.6 V

 $V_{OUT\_EOVP} = \frac{R_{E11} + R_{E12}}{R_{E12}}$  $\frac{1 + R_{E12}}{R_{E12}} \times V_{EOVP}$  $=\frac{510 k\Omega + 24 k\Omega}{34 k\Omega}$  $\frac{324 \times 124 \times 12}{24 \times \Omega} \times 2.5 V \approx 55.6$  (Typ) [V]

Where:

 $V_{OUT\ EOVP}$  is the OVP (LED open) detection voltage.

 $R<sub>E11</sub>$ ,  $R<sub>E12</sub>$  resistor will be the current discharge path for the output capacitor when PWM = L.

Improperly the resistor value can increase VOUT ripple and cause the LED to flicker. Therefore, it is recommended to select ROPUD1 in the range of 500 kΩ to 1000 kΩ.

Sufficient verification for LED flickering is required with actual application as behavior differs by characteristic of output capacitor and LED. (V<sub>OUT</sub> drop can be prevented by inserting bigger output capacitor or R<sub>E11</sub> resistance.)

#### **6 Diode and MOSFET Selection**

#### **Selection of MOSFET MN1**

Select a MOSFET (M1) whose VDS rating is higher than the maximum voltage for OVP (LED open) detection.

$$
MN1 V_{DS} > V_{OUT\_EOVP\_MAX} = \frac{R_{E11} + R_{E12}}{R_{E12}} \times V_{EOVP\_MAX}
$$

$$
= \frac{510 k\Omega + 24 k\Omega}{24 k\Omega} \times 2.625 V \approx 58.4 (Max)
$$
 [V]

Where:

 $MN1$   $V_{DS}$  is the maximum rating voltage between drain and source of MN1.  $V_{OUT\ EOVP\ MAX}$  is the maximum external over voltage detection voltage.

The RMS current rating (I<sub>DS RMS</sub>) flowing between the drain - source of MN1 can be calculated as follows.

$$
I_{DS\_RMS} = 1.3 \times \sqrt{(I_{L\_AVE})^2 \times D_{SW}}
$$

Where:

 $I_{L \, AVE}$  is the mean inductor current.  $D_{SW}$  is the switching duty.

A loss of MN1 is calculated next. The loss of MN1 has switching loss  $P_{LOS51}$  and MN1 ON resistance loss  $P_{LOS52}$ . Switching loss PLoss<sub>1</sub> and MN1 ON resistance loss PLoss<sub>2</sub> can be calculated as follows.

$$
P_{LOSS1} = \frac{(t_R + t_F)}{2} \times f_{SW} \times (V_{OUT} + V_{D1}) \times I_{L_AVE}
$$

$$
P_{LOSS2} = I_{L\_AVE}^2 \times R_{ON} \times D_{SW}
$$

Where:

 $t_R$  is the rise time of MN1 drain-source.

 $t_F$  is the fall time of MN1 drain-source.

 $V_{D1}$  is the forward voltage of D1.

 $R_{ON}$  is the ON resistance of MN1.

#### **6 Diode and MOSFET Selection - continued**

#### **Selection of rectifier diode D1**

For power consumption reduction, use a schottky barrier diode for rectification diode D1. The withstand voltage rating of the diode shall be higher than the OVP (LED Open) detection voltage. In addition, schottky barrier diode with low leakage current shall be selected if PWM dimming is used. Because the leakage current increases with higher temperature environment, the output capacitor can be discharged in PWM = L which may result that LED current will be unstable. The current limit of D1 can be calculated in the following formula.

$$
I_{D1} = I_{L_AVE} \times (1 - D_{SW})
$$

Where:

 $I_{L \, AVE}$  is the mean inductor current.  $D_{SW}$  is the DC/DC switching duty.

### **Selection of MOSFET MP1**

Consider margin and set the rated voltage rather higher than the actual usage condition for LED current and output voltage.

#### **Selection of transistor Q1 for current clamp**

It is recommended to insert Q1 to control the flow of excessive large current at the time of anode ground fault. By inserting Q1, the set current is clamped by the Vf of Q1, so the withstand current of MP1 can be suppressed.

For example, when Vf = 0.5 V, the current is clamped at about 3 times the set current. Select the V<sub>CE</sub> of Q1 that satisfies the following formula.

$$
V_{CE} > V_{OUT\_EOVP\_MAX}
$$

Where:

 $V_{CE}$  is the withstand voltage between collector and emitter of Q1.

Also, select in consideration of hFE, speed and saturation voltage.

#### **7 Output Capacitor Selection**

Output capacitance includes two purposes. The first is to reduce output ripple. The second is to supply current to LED when MOSFET (MN1) is switched on. The output voltage ripple is influenced by both bulk capacitance and ESR. (When a ceramic capacitor is used, most of the ripple caused by bulk capacitance.) Bulk capacitance and the ESR can be calculated in lower formula.

$$
C_{OUT} \ge I_{LED} \times \frac{D_{SW\_MAX}}{\Delta V_{COUNT} \times f_{SW\_MIN}}
$$

$$
R_{ESR} < \frac{\Delta V_{ESR}}{I_{L\_MAX}}
$$

Where:

 $\Delta V_{COUT}$  is the influence with the capacitor among output ripple.

 $\Delta V_{ESR}$  is the ripple which occurs in the ESR of the output capacitor.

 $f_{SW~MIN}$  is the minimum switching frequency.

The total output ripple permitted here can be expressed as product of LED current ripple and the equivalent resistance of the LED. This equivalent resistance is defined as "ΔV / ΔI of the LED current", and it is necessary to calculate from I-V properties in the data sheet of the selected LED. When the application condition is the number of the driven LED = 8 pcs (equivalent resistance 0.2  $\Omega$  / LED), LED current = 1 A (I<sub>L MAX</sub> = 4.74 A), switching duty = 72 % (V<sub>IN</sub> = 8 V, V<sub>OUT</sub> = 28 V), switching frequency = 400 kHz, LED current ripple = 5 %. Then the total output ripple can be calculated as follows.

$$
V_{OUT\_RIPPLE} = 1 A \times 5 \% \times (0.2 \Omega \times 8) = 80
$$
 [mV]

Where:

 $V_{OUT\_RIPPLE}$  is the V<sub>OUT</sub> ripple voltage.

If bulk capacitance causes 95 % among total output ripple, the output capacitor is calculated as follows.

$$
C_{OUT} \ge 1 \times \frac{0.72}{0.08 \times 0.95} \times \frac{1}{400 \, kHz} \approx 23.7 \quad [\mu \text{F}]
$$
\n
$$
R_{ESR} < \frac{V_{OUT\_RIPPLE}}{I_{L\_MAX}} = \frac{0.08}{4.74} \approx 16.9 \quad [\text{m}\Omega]
$$
# **7 Output Capacitor Selection - continued**

However, the capacitance of output capacitor mentioned above is minimum capacitance. Therefore, select parts considering the tolerance of the capacitor and DC bias properties. Furthermore, because small external part connected to output may lead to bigger ripple on output voltage, which may result in LED flickering, sufficient verification of the actual application is required. Increase output capacitors if judged to be required from the verification. In addition, an acoustic noise may be produced by the piezoelectric effect of the ceramic capacitor during PWM dimming. Low ESR electrolytic capacitor used together with a ceramic capacitor may reduce this noise. But capacitance may largely decrease with a change of the voltage with the ceramic capacitor and may not accord with the numerical value calculated from theory.

# **8 Input Capacitor Selection**

In DC/DC converter, since peak current flows between input and output, a capacitor is also required in the input side. Therefore, low ESR capacitors with capacitor of 10 µF or more and ESR component of 100 mΩ or less are recommended as input capacitors. If a capacitor out of the range is selected, an excessive ripple voltage may be superimposed on the input voltage and the LSI may malfunction.

$$
C_{IN} \ge \frac{\Delta I_L}{8 \times V_{IN\_RIPPLE} \times f_{SW}}
$$

Where:

 $V_{IN\_RIPPLE}$  is the V<sub>IN</sub> ripple voltage.

# **9 Feedback Compensation**

●Concerning stability condition of application.

Stability condition for system with negative feedback is as shown below.

Phase-lag when gain is 1 (0 dB) is no more than 150° (namely, phase margin is 30° or more).

- Further, since DC/DC converter application is sampled by switching frequency, GBW of the entire system is set to be 1 / 10 or less of switching frequency. To wrap up, target characteristics of application are as shown below.
- ●Phase-lag when gain is 1 (0 dB) is 150° or less (namely, phase margin is 30° or more).
- ●GBW at the time (namely, frequency when gain is 0 dB) is 1/10 or less of switching frequency. Therefore, in order to raise responsiveness by limiting GBW, higher switching frequency is required.
- ●Phase margin: 60° or more
- ●GBW: 1/20 or less of switching frequency.

The knack for securing stability feedback compensation is to insert phase-lead  $f_{21}$  near GBW. GBW is determined by  $C_{\text{OUT}}$ and phase-lag f  $_P$  due to output impedance R<sub>L</sub> (=  $V_{\text{OUT}}/I_{\text{LED}}$ ). They are shown in the following formula.

# **Phase-lead**

$$
f_{Z1} = \frac{1}{2 \pi \times C_{P1} \times R_{P1}}
$$

# **Phase-lag**

$$
f_P = \frac{1}{2 \pi \times R_L \times C_{OUT}}
$$

$$
R_L = \frac{V_{OUT}}{I_{LED}}
$$

As described above, secure phase margin. R<sup>L</sup> value at maximum load should be inserted. In addition, with boost DC/DC, right half plane zero (RHP zero) is to be considered. This zero has a characteristic of zero as a gain and as the pole with phase. Because it causes an oscillation when this zero effects on a control loop, it is necessary to bring GBW just before RHP zero. RHP zero fz2 can be calculated with an equation below and shows good characteristic by setting GBW to be lower than 1/10 of RHP zero or less.

$$
f_{Z2} = \frac{R_L \times (\frac{V_{IN}}{V_{OUT}})^2}{2 \pi \times L}
$$

# **9 Feedback Compensation - continued**

Particularly when supply voltage rises and gets close to output voltage, the switching output becomes irregular and ripple of the output voltage increases. Ripple of the LED current may thereby get bigger.

Since this setting is obtained by simplified, not strict, calculation, adjustment by actual equipment may be required in some cases.

Further, since these characteristics will vary depending upon substrate layout, load condition, etc., confirm satisfactorily with actual equipment when planning mass production.

#### **10 Actual Operation Confirmation**

Select external parts based on verification with actual equipment since characteristics will vary depending on various factors such as load current, input voltage, output voltage, inductor value, load capacitance, switching frequency and mounting pattern.

#### **About the attention point at the time of the PCB layout**

- 1. Locate the decoupling capacitor of  $C_{VIN}$ ,  $C_{VREG5}$  and  $C_{VDRV7}$  close to the LSI pin as much as possible.
- 2. RRT locates it close to the RT pin.
- 3. Because high current may flow in PGNDx, lower impedance.
- 4. Prevent noise to be applied to the EN, NTCx, COMPx, RT, PWMDx, SSUx, SNSPx and SNSNx pins.
- 5. As the GLx, CSx and PDRVx pins are switching, be careful not to affect the neighboring patterns.
- 6. There is EXP-PAD on the back side of the package.
- 7. For noise reduction, it is recommended that PGNDx of  $R_{CSX}$  and PGNDx of  $C_{\text{OUTX}}$  have common grounds. In addition, consider the PCB layout so that the current path of MNx  $\rightarrow$  Rcsx, Rcsx  $\rightarrow$  PGNDx and the current path of MNx  $\rightarrow$  Dx  $\rightarrow$  $C<sub>OUT</sub> \rightarrow$  PGNDx are the shortest and with the lowest impedance on the same surface without vias etc.



# **PCB Layout Example**

# **I/O Equivalence Circuits**



# **I/O Equivalence Circuits- continued**



# **Operational Notes**

## **1. Reverse Connection of Power Supply**

Connecting the power supply in reverse polarity can damage the IC. Take precautions against reverse polarity when connecting the power supply, such as mounting an external diode between the power supply and the IC's power supply pins.

## **2. Power Supply Lines**

Design the PCB layout pattern to provide low impedance supply lines. Furthermore, connect a capacitor to ground at all power supply pins. Consider the effect of temperature and aging on the capacitance value when using electrolytic capacitors.

### **3. Ground Voltage**

Ensure that no pins are at a voltage below that of the ground pin at any time, even during transient condition.

# **4. Ground Wiring Pattern**

When using both small-signal and large-current ground traces, the two ground traces should be routed separately but connected to a single ground at the reference point of the application board to avoid fluctuations in the small-signal ground caused by large currents. Also ensure that the ground traces of external components do not cause variations on the ground voltage. The ground lines must be as short and thick as possible to reduce line impedance.

# **5. Recommended Operating Conditions**

The function and operation of the IC are guaranteed within the range specified by the recommended operating conditions. The characteristic values are guaranteed only under the conditions of each item specified by the electrical characteristics.

#### **6. Inrush Current**

When power is first supplied to the IC, it is possible that the internal logic may be unstable and inrush current may flow instantaneously due to the internal powering sequence and delays, especially if the IC has more than one power supply. Therefore, give special consideration to power coupling capacitance, power wiring, width of ground wiring, and routing of connections.

#### **7. Testing on Application Boards**

When testing the IC on an application board, connecting a capacitor directly to a low-impedance output pin may subject the IC to stress. Always discharge capacitors completely after each process or step. The IC's power supply should always be turned off completely before connecting or removing it from the test setup during the inspection process. To prevent damage from static discharge, ground the IC during assembly and use similar precautions during transport and storage.

# **8. Inter-pin Short and Mounting Errors**

Ensure that the direction and position are correct when mounting the IC on the PCB. Incorrect mounting may result in damaging the IC. Avoid nearby pins being shorted to each other especially to ground, power supply and output pin. Inter-pin shorts could be due to many reasons such as metal particles, water droplets (in very humid environment) and unintentional solder bridge deposited in between pins during assembly to name a few.

# **9. Unused Input Pins**

Input pins of an IC are often connected to the gate of a MOS transistor. The gate has extremely high impedance and extremely low capacitance. If left unconnected, the electric field from the outside can easily charge it. The small charge acquired in this way is enough to produce a significant effect on the conduction through the transistor and cause unexpected operation of the IC. So unless otherwise specified, unused input pins should be connected to the power supply or ground line.

# **Operational Notes – continued**

#### **10. Regarding the Input Pin of the IC**

This monolithic IC contains P+ isolation and P substrate layers between adjacent elements in order to keep them isolated. P-N junctions are formed at the intersection of the P layers with the N layers of other elements, creating a parasitic diode or transistor. For example (refer to figure below):

When GND > Pin A and GND > Pin B, the P-N junction operates as a parasitic diode. When GND > Pin B, the P-N junction operates as a parasitic transistor.

Parasitic diodes inevitably occur in the structure of the IC. The operation of parasitic diodes can result in mutual interference among circuits, operational faults, or physical damage. Therefore, conditions that cause these diodes to operate, such as applying a voltage lower than the GND voltage to an input pin (and thus to the P substrate) should be avoided.



Figure 125. Example of Monolithic IC Structure

#### **11. Ceramic Capacitor**

When using a ceramic capacitor, determine a capacitance value considering the change of capacitance with temperature and the decrease in nominal capacitance due to DC bias and others.

#### **12. Thermal Shutdown Circuit (TSD)**

This IC has a built-in thermal shutdown circuit that prevents heat damage to the IC. Normal operation should always be within the IC's maximum junction temperature rating. If however the rating is exceeded for a continued period, the junction temperature (Tj) will rise which will activate the TSD circuit that will turn OFF power output pins. When the Tj falls below the TSD threshold, the circuits are automatically restored to normal operation.

Note that the TSD circuit operates in a situation that exceeds the absolute maximum ratings and therefore, under no circumstances, should the TSD circuit be used in a set design or for any purpose other than protecting the IC from heat damage.

#### **13. Over Current Protection Circuit (OCP)**

This IC incorporates an integrated overcurrent protection circuit that is activated when the load is shorted. This protection circuit is effective in preventing damage due to sudden and unexpected incidents. However, the IC should not be used in applications characterized by continuous operation or transitioning of the protection circuit.

#### **14. Functional Safety**

"ISO 26262 Process Compliant to Support ASIL-\*"

A product that has been developed based on an ISO 26262 design process compliant to the ASIL level described in the datasheet.

"Safety Mechanism is Implemented to Support Functional Safety (ASIL-\*)"

A product that has implemented safety mechanism to meet ASIL level requirements described in the datasheet.

"Functional Safety Supportive Automotive Products"

A product that has been developed for automotive use and is capable of supporting safety analysis with regard to the functional safety.

Note: "ASIL-\*" is stands for the ratings of "ASIL-A", "-B", "-C" or "-D" specified by each product's datasheet.

# **Ordering Information**



# **Marking Diagram**



# **Datasheet**



# **Revision History**



# **Notice**

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	- [f] Sealing or coating our Products with resin or other coating materials
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	- [h] Use of the Products in places subject to dew condensation
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- 8. Confirm that operation temperature is within the specified range described in the product specification.
- 9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

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For details, please refer to ROHM Mounting specification

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